Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/830,153	SEKIYA, TAKURO
Examiner	Art Unit

2853

Julian D. Huffman

SEARCHED					
Class	Subclass	Date	Examiner		
347	102	5/5/2006	JH		

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
347	102	5/5/2006	JH		
			nyi		
			-		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated Search	5/5/2006	JH	